



EMC TEST REPORT
EN 55032:2015+A1:2020
EN 55035:2017+A11:2020
EN IEC 61000-3-2:2019+A1:2021
EN 61000-3-3:2013+A1:2019+A2:2021
MEASUREMENT AND TEST REPORT

For

OpenVox Communication Co., Ltd.

Room 624, 6/F, Tsinghua Information Port, Qingqing Road, Longhua Street, Longhua District,
Shenzhen, Guangdong, China

Model:MAG1100

2024-03-12

| | |
|---|---|
| This Report Concerns: Original Report | Equipment Type: Analog Gateway |
| Test Engineer: | Leon Gao/ <i>Leon Gao</i> |
| Report Number: | TH2403055-C01-R01 |
| Test Date: | 2024-03-06 to 2024-03-12 |
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Note: This test report is limited to the above client company and the product model only. It may not be duplicated without prior written consent of TianHai Compliance Testing Laboratory Ltd.



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1 - SUMMARY OF STANDARDS AND RESULTS

1.1 DESCRIPTION OF STANDARDS AND RESULTS

The EUT have been tested according to the applicable standards as referenced below.

| EMISSION | | | | |
|--|---------------------------------------|---------------------------------------|--------------------|---------|
| Description of Test Item | Test Standard | Basic Standard | Requirement | Results |
| Conducted disturbance | EN 55032:2015 +A1:2020 | EN 55032:2015 +A1:2020 | See Section 4 | PASS |
| Asymmetric mode conducted emission | EN 55032:2015 +A1:2020 | EN 55032:2015 +A1:2020 | See Section 5 | PASS |
| Radiated disturbance | EN 55032:2015 +A1:2020 | EN 55032:2015 +A1:2020 | See Section 6 | PASS |
| Harmonic current emissions | EN IEC 61000-3-2 :2019+A1:2021 | EN IEC 61000-3-2 :2019+A1:2021 | See Section 7 | PASS |
| Voltage fluctuations & flicker | EN 61000-3-3:2013 +A1:2019+A2:2021 | EN 61000-3-3:2013 +A1:2019+A2:2021 | See Section 8 | PASS |
| IMMUNITY | | | | |
| Description of Test Item | Test Standard | Basic Standard | Test configuration | Results |
| Electrostatic discharge (ESD) | EN 55035:2017 +A11:2020 | IEC 61000-4-2:2008 | See Section 9.1 | PASS |
| Radio-frequency, Continuous radiated disturbance | EN 55035:2017 +A11:2020 | IEC 61000-4-3:2020 | See Section 9.2 | PASS |
| Electrical fast transient (EFT) | EN 55035:2017 +A11:2020 | IEC 61000-4-4:2012 | See Section 9.3 | PASS |
| Surge (Input a.c. power ports) | EN 55035:2017 +A11:2020 | IEC 61000-4-5:2014 +AMD1:2017 | See Section 9.4 | PASS |
| Radio-frequency, Continuous conducted disturbance | EN 55035:2017 +A11:2020 | IEC 61000-4-6:2013 | See Section 9.5 | PASS |
| Power frequency magnetic field* | / | / | See Note | N/A |
| Voltage dips and interruptions | EN 55035:2017 +A11:2020 | IEC 61000-4-11:2020 | See Section 9.6 | PASS |
| <p>Note: N/A is an abbreviation for Not Applicable “*” : The EUT does not contain devices susceptible to magnetic fields; therefore the Power-Frequency Magnetic Fields test is not necessary.</p> | | | | |



| Internal Source | Upper Frequency |
|------------------|--|
| Below 108MHz | 1GHz |
| 108MHz to 500MHz | 2GHz |
| 500MHz to 1GHz | 5GHz |
| Above 1GHz | 5 times the highest frequency or 6GHz, whichever is less |

1.2 DESCRIPTION OF PERFORMANCE CRITERIA

General Performance Criteria

General performance criteria are defined in 1.2.1, 1.2.2 and 1.2.3. These criteria shall be used during the testing of primary functions where no relevant annex is applicable.

When assessing the impact of a disturbance on a function, the assessment should take into consideration the function's performance prior to the application of the disturbance and only identify as failures those changes in performance that are a result of the disturbance.

1.2.1 Performance criterion A

The equipment shall continue to operate as intended without operator intervention. No degradation of performance, loss of function or change of operating state is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

1.2.2 Performance criterion B

During the application of the disturbance, degradation of performance is allowed. However, no unintended change of actual operating state or stored data is allowed to persist after the test. After the test, the equipment shall continue to operate as intended without operator intervention; no degradation of performance or loss of function is allowed, below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level (or the permissible performance loss), or recovery time, is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

1.2.3 Performance criterion C

Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. A reboot or re-start operation is allowed. Information stored in non-volatile memory, or protected by a battery backup, shall not be lost.



2 - GENERAL INFORMATION

2.1 PRODUCT DESCRIPTION FOR EQUIPMENT UNDER TEST

Client Information

Applicant: OpenVox Communication Co., Ltd.
 Address: Room 624, 6/F, Tsinghua Information Port, Qingqing Road, Longhua Street, Longhua District, Shenzhen, Guangdong, China
 Manufacturer: OpenVox Communication Co., Ltd.
 Address: Room 201, Building I, Jinchangda, Building 00082, Shangwei Industrial Zone, Zhangkengjing Community, Guanhu Street, Longhua District, Shenzhen, Guangdong, China

General Description of E.U.T

EUT Name: Analog Gateway
 Trade Mark: OpenVox
 Model No.: MAG1100
 Sample No.: TH2403055
 Ratings: Input: AC 100-240V, 50/60Hz, 1.5A ,120W
 Test Mode: Normal Working
 Note: /

2.2 STATEMENT OF THE MEASUREMENT UNCERTAINTY TEST FACILITY

The data and results referenced in this document are true and accurate. The reader is cautioned that there may be errors within the calibration Limits of the equipment and facilities. The measurement uncertainty was calculated for all measurements listed in this test report acc. To CISPR 16-4-2 "Specification for radio disturbance and immunity measuring apparatus and methods - Part 4-2: Uncertainties, statistics and limit modelling – Measurement instrumentation uncertainty" and is documented in the LCS quality system acc. To DIN EN ISO/IEC 17025. Furthermore, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device.

2.3 MEASUREMENT UNCERTAINTY

| Test | Parameters | Expanded uncertainty (U _{lab}) | Expanded uncertainty (U _{cispr}) |
|--|---|--|--|
| Conducted Emission | Level accuracy (9kHz to 150kHz) (150kHz to 30MHz) | ±2.52 dB ±2.36 dB | ±3.80 dB ±3.40 dB |
| Power disturbance | Level accuracy (30MHz to 300MHz) | ±3.20 dB | ±4.50 dB |
| Electromagnetic Radiated Emission (3-loop) | Level accuracy (9kHz to 30MHz) | ±3.10dB | N/A |
| Radiated emission | Level accuracy (30MHz to 1000MHz) | ±5.78dB | ±6.30dB |



| | | | |
|-----------------------------------|-----------------------------------|---------|-----|
| | Level accuracy (above 1000MHz) | ±4.62dB | N/A |
| Mains Harmonic | Voltage | ±1.80% | N/A |
| Voltage Fluctuations & Flicker | Voltage | ±0.64% | N/A |

(1) Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the apparatus.

(2) The reported expanded uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor of k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

(3) The measurement uncertainty is not included in the test result.

2.4 TEST LOCATION

All tests were performed at Shenzhen Tianhai Test Technology Co., Ltd.
125-126, No.66, Zhangge Road ,Zhangge Community, Fucheng Street, Longhua District,
Shenzhen, Guangdong Province, P.R. China

2.5 PRINCIPLE OF CONFIGURATION SELECTION

Emission: The equipment under test (EUT) was configured to measure its highest possible radiation level. The test modes were adapted accordingly in reference to the instructions for use.

Immunity: The equipment under test (EUT) was configured to have its highest possible susceptibility against the tested phenomena. The test modes were adapted accordingly in reference to the instructions for use.

2.6 TEST OPERATION

Test operation refers to test setup in chapter 4 & 5 & 6 & 7 & 8 & 9.
Pretest in all operation modes, and find out the worst case for compliance test.

2.7 SPECIAL ACCESSORIES AND AUXILIARY EQUIPMENT

The EUT was tested together with the following accessories:

| Kind of Equipment | Manufacturer | Type | S/N |
|-------------------|--------------|---------------|-----|
| Notebook | DELL | Inspiron 3501 | / |

The EUT was tested with following cables:

| Cable name | Length (m) | Shield | Core No. | Detachable |
|------------|------------|--------|----------|------------|
| LAN cable | 1.8m | No | 0 | No |



3 - TEST EQUIPMENT LIST AND DETAILS

| Kind of Equipment | Manufacturer | Type | S/N | Calibrate until |
|---------------------------------------|--------------------|------------------|----------------|-----------------|
| Conducted Emission | | | | |
| EMI Test Receiver | R&S | ESR7 | 102333 | 2024-11-13 |
| L.I.S.N | Schwarzbeck | NNLK 8128 | 5089 | 2024-11-13 |
| 8-Wire ISN CAT6 | Schwarzbeck | NTFM 8158 | 231 | 2024-11-13 |
| Pulse Limiter | Schwarzbeck | VTSD 9561-F | 847 | 2024-11-13 |
| Test software | EZ | EMC-CON 3A1.1 | / | / |
| Disturbance power | | | | |
| EMI Test Receiver | R&S | ESR7 | 102333 | 2024-11-13 |
| EMI Absorbing Clamp | Teseq | MDS 21B | 58115 | 2024-11-20 |
| Test software | EZ | EMC-CON 3A1.1 | / | / |
| LLAS Radiated Disturbance (2m) | | | | |
| EMI Test Receiver | R&S | ESR7 | 102333 | 2024-11-13 |
| Loop Antenna | Schwarzbeck | HXYZ 9170 | 353 | 2024-11-13 |
| Test software | EZ | EMC-CON 3A1.1 | / | / |
| Radiated Emission (3m) | | | | |
| EMI Test Receiver | R&S | ESR7 | 102333 | 2024-11-13 |
| MXA Signal Analyzer | Keysight | N9020A | MY51281805 | 2024-04-20 |
| Bilog Antenna | Schwarzbeck | VULB 9168 | 01148 | 2024-11-20 |
| Pre-Amplifier | Schwarzbeck | BBV 9718 B | 00109 | 2024-11-13 |
| Pre-Amplifier | Schwarzbeck | BBV 9743 B | 00253 | 2024-11-13 |
| Pre-Amplifier | GUANGGU ELECTRONIC | GLNA18-40GK-5372 | 20210331001 | 2024-11-13 |
| Active Loop Antenna | Schwarzbeck | FMZB 1519 B | 00148 | 2024-11-13 |
| Horn Antenna | Schwarzbeck | BBHA 9120 | 02379 | 2024-11-20 |
| Test software | FALA | / | FA-03A2 RE | / |
| Harmonics & Flicker | | | | |
| 5kVA AC Power Source | AMETEK CTS | 5001iX-CTS-400 | 2046A03237 | 2024-11-13 |
| Signal Conditioning Unit | AMETEK CTS | PACS-1 | 2046A03238 | 2024-11-13 |
| Test software | AMETEK CTS | CTS 4 | Version 4.26.0 | / |
| Electrostatic discharge (ESD) | | | | |
| ESD Simulator | TESEQ | NSG 437 | 1569 | 2024-11-15 |



| Radio-frequency,Continuous radiated disturbance (RS) | | | | |
|--|-------------|-------------------|----------------|------------|
| Signal generator | R&S | SMB 100A | 113650 | 2024-04-20 |
| Power meter | Agilent | E4417A | MY45100899 | 2024-04-20 |
| Power sensor | Agilent | E9321A | US40390494 | 2024-04-20 |
| Power sensor | Agilent | E9322A | MY44420219 | 2024-04-20 |
| Power amplifier | Micotop | MPA-80-1000-250 | MPA2112426 | 2024-04-20 |
| Power amplifier | Micotop | MPA-1000-6000-100 | MPA2201013 | 2024-04-20 |
| Stacked Log. Periodic Antenna | Schwarzbeck | STLP 9129 | 201 | N/A |
| Field strength probe | PMM | EP601 | 811ZX10673 | 2024-04-20 |
| RF Switch | Emtrace | SW X4 | / | N/A |
| Test Software | Emtrace | EM 3 | V1.2.1 | N/A |
| Electrical fast transient (EFT) | | | | |
| Burst Tester | 3C TEST | EFT 500T | ES027000120015 | 2024-11-13 |
| Coupling Clamp | 3C TEST | CCC 100 | CCC 20092269 | 2024-11-13 |
| CCS | 3C TEST | V4.2.7 | ES027000120015 | / |
| Surge | | | | |
| Surge simulator | 3C TEST | CWS 600CT | ES058000920005 | 2024-11-13 |
| Three phases CDN | 3C TEST | SPN 3832T | ES0911910 | 2024-11-13 |
| CDN for unshielded symmetrical high-speed Telecom cable | 3C TEST | CDN405T8A | ES064001220010 | 2024-11-13 |
| CDN for Telecom cable | 3C TEST | CDN405M40-5 | ES1071910 | 2024-11-13 |
| CWS | 3C TEST | V1.0.5.2 | ES058000920005 | / |
| Radio-frequency,Continuous conducted disturbance (CS) | | | | |
| Conducted Immunity Test System | 3C TEST | CST 1075 | ES096000120008 | 2024-11-13 |
| 6dB Attenuator | 3C TEST | DTC75-6 | ES095000120006 | 2024-11-13 |
| Single phase CDN | 3C TEST | CDN M2M3 | ES064002620007 | 2024-11-13 |
| Three phases CDN | 3C TEST | CDN M5-16 | ES064003320004 | 2024-11-13 |
| Calibration Set | 3C TEST | CDN 100KIT | ES064002820016 | 2024-11-13 |
| Calibration Set | 3C TEST | EM CL100KIT | EM C20032816 | 2024-11-13 |
| EM-Clamp | 3C TEST | EM CL100 | EM C20032811 | 2024-11-13 |

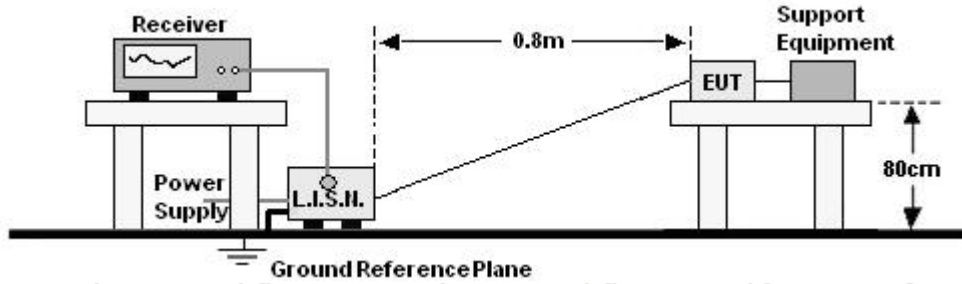


| | | | | |
|---|---------|------------|----------------|------------|
| EMC-s | SKET | V1.4.0.54 | / | / |
| Power Frequency Magnetic Field (PFMF) | | | | |
| PFMF simulator | 3C TEST | MFS 400 | ES045000720001 | 2024-11-13 |
| Transformer | 3C TEST | MFT 400 | ES046000220003 | 2024-11-13 |
| Magnetic field antenna | 3C TEST | TCXS111 | TCXS20060910 | 2024-11-13 |
| CWS | 3C TEST | V4.2.7 | ES045000720001 | / |
| Voltage dips & Voltage interruptions | | | | |
| Power failure simulator | 3C TEST | PFS 2216SD | ES049001220003 | 2024-11-13 |
| CCS | 3C TEST | V4.2.8 | ES049001220003 | / |



4 - CONDUCTED EMISSION MEASUREMENT

4.1 BLOCK DIAGRAM OF TEST SETUP



4.2 LIMITS

| Frequency range (MHz) | Class B Limits (dB μ V) | |
|-----------------------|-----------------------------|---------|
| | Quasi-peak | Average |
| 0.15 ~ 0.5 | 66 - 56 | 56 - 46 |
| 0.50 ~ 5 | 56 | 46 |
| 5 ~ 30 | 60 | 50 |

Remark: (1) The lower limit shall apply at the transition frequencies.

(2) The limit decreases in line with the logarithm of the frequency in the range of 150 kHz to 0.5MHz.

(3) All emanations from a class B digital device or system, including any network of conductors and apparatus connected thereto, shall not exceed the level of field strengths specified above.

4.3 TEST PROCEDURE

The EUT is put on the plane 0.8m high above the ground by insulating support and connected to the AC mains through a Line Impedance Stability Network (L.I.S.N). This provided a 50ohm coupling impedance for the tested equipments. Both sides of AC line are investigated to find out the maximum conducted emission according to the EN 55032 regulations during conducted emission measurement.

The bandwidth of the field strength meter is set at 9kHz.

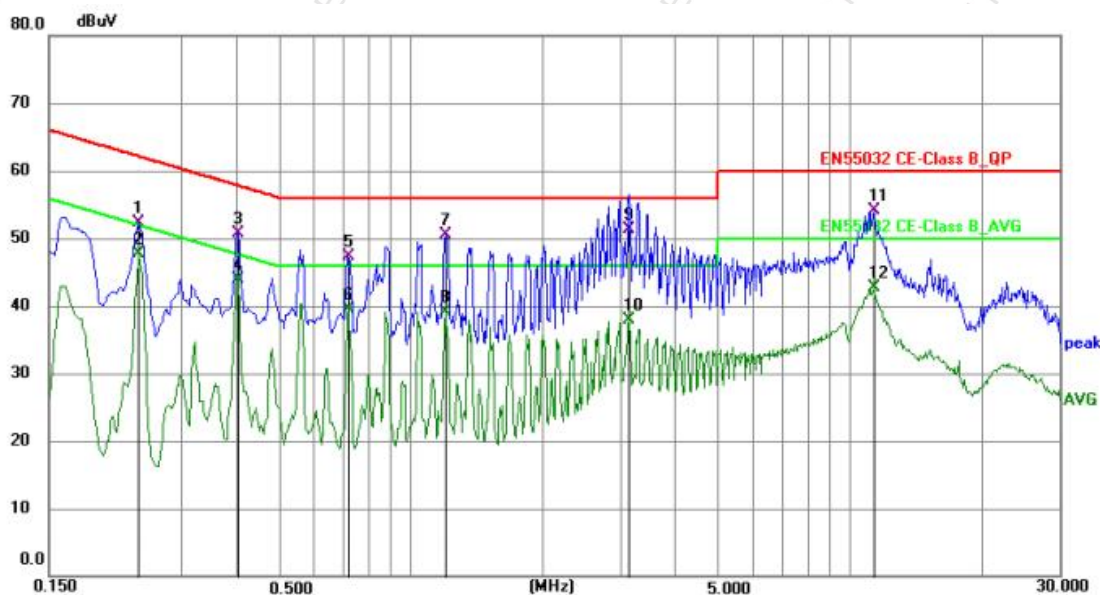
The frequency range from 150kHz to 30MHz is investigated. The scanning waveform please refer to the next page.



4.4 TEST RESULTS AND DATA

EUT: Analog Gateway
 M/N: MAG1100
 Test Mode: Normal Working
 Test Voltage : AC 230V/50Hz
 Temperature: 23°C
 Humidity: 55%
 Atmosphere pressure: 101Kpa
 Test Results: Pass

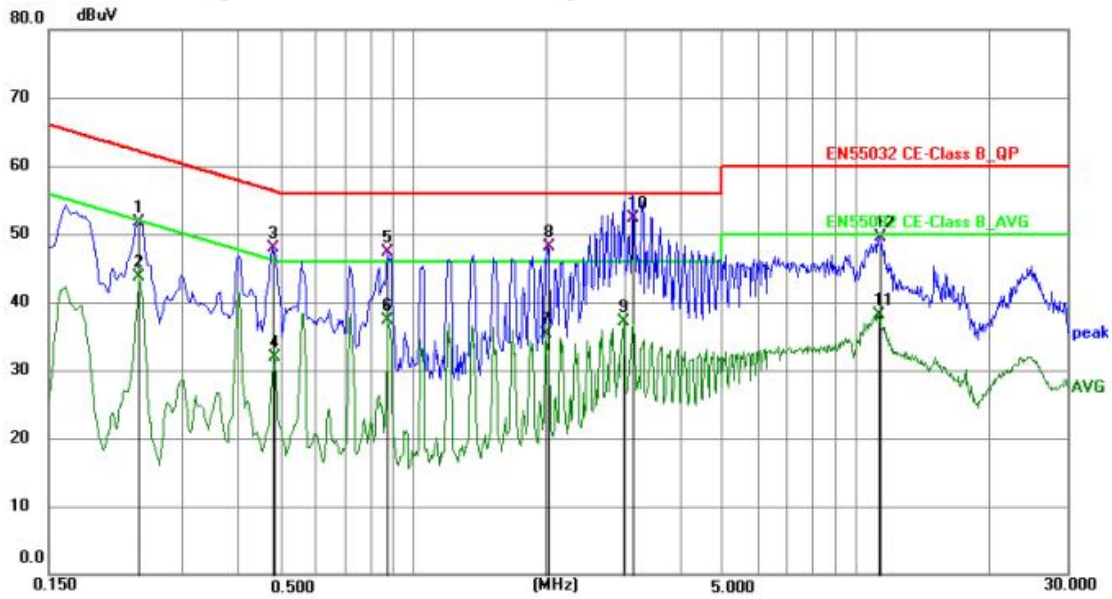
Phase:L1



| No. | Frequency (MHz) | Reading (dBuV) | Factor (dB) | Level (dBuV) | Limit (dBuV) | Margin (dB) | Detector | P/F |
|-----|-----------------|----------------|-------------|--------------|--------------|-------------|----------|-----|
| 1 | 0.2400 | 41.69 | 10.59 | 52.28 | 62.10 | -9.82 | QP | P |
| 2 | 0.2400 | 37.18 | 10.59 | 47.77 | 52.10 | -4.33 | AVG | P |
| 3 | 0.4020 | 40.07 | 10.60 | 50.67 | 57.81 | -7.14 | QP | P |
| 4 * | 0.4020 | 33.38 | 10.60 | 43.98 | 47.81 | -3.83 | AVG | P |
| 5 | 0.7170 | 36.68 | 10.64 | 47.32 | 56.00 | -8.68 | QP | P |
| 6 | 0.7215 | 28.82 | 10.64 | 39.46 | 46.00 | -6.54 | AVG | P |
| 7 | 1.1985 | 39.89 | 10.66 | 50.55 | 56.00 | -5.45 | QP | P |
| 8 | 1.1985 | 28.41 | 10.66 | 39.07 | 46.00 | -6.93 | AVG | P |
| 9 | 3.1560 | 40.70 | 10.70 | 51.40 | 56.00 | -4.60 | QP | P |
| 10 | 3.1560 | 27.20 | 10.70 | 37.90 | 46.00 | -8.10 | AVG | P |
| 11 | 11.3320 | 43.27 | 10.79 | 54.06 | 60.00 | -5.94 | QP | P |
| 12 | 11.3320 | 31.86 | 10.79 | 42.65 | 50.00 | -7.35 | AVG | P |



Phase:N

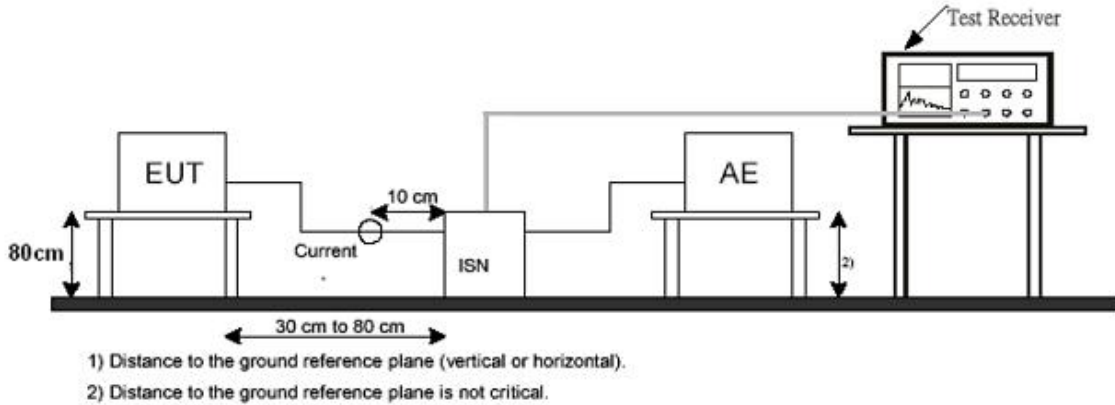


| No. | Frequency (MHz) | Reading (dBuV) | Factor (dB) | Level (dBuV) | Limit (dBuV) | Margin (dB) | Detector | P/F |
|------|-----------------|----------------|-------------|--------------|--------------|-------------|----------|-----|
| 1 | 0.2400 | 41.17 | 10.59 | 51.76 | 62.10 | -10.34 | QP | P |
| 2 | 0.2400 | 33.10 | 10.59 | 43.69 | 52.10 | -8.41 | AVG | P |
| 3 | 0.4785 | 37.28 | 10.62 | 47.90 | 56.37 | -8.47 | QP | P |
| 4 | 0.4830 | 21.31 | 10.62 | 31.93 | 46.29 | -14.36 | AVG | P |
| 5 | 0.8745 | 36.68 | 10.65 | 47.33 | 56.00 | -8.67 | QP | P |
| 6 | 0.8790 | 26.75 | 10.65 | 37.40 | 46.00 | -8.60 | AVG | P |
| 7 | 1.9950 | 24.59 | 10.68 | 35.27 | 46.00 | -10.73 | AVG | P |
| 8 | 2.0220 | 37.47 | 10.68 | 48.15 | 56.00 | -7.85 | QP | P |
| 9 | 2.9940 | 26.33 | 10.69 | 37.02 | 46.00 | -8.98 | AVG | P |
| 10 * | 3.1380 | 41.60 | 10.70 | 52.30 | 56.00 | -3.70 | QP | P |
| 11 | 11.2060 | 27.18 | 10.85 | 38.03 | 50.00 | -11.97 | AVG | P |
| 12 | 11.3050 | 38.65 | 10.86 | 49.51 | 60.00 | -10.49 | QP | P |



5 - ASYMMETRIC MODE CONDUCTED EMISSION MEASUREMENT

5.1 BLOCK DIAGRAM OF TEST SETUP



5.2 LIMITS

| Frequency range (MHz) | Class B Limits (dB μ V) | |
|-----------------------|-----------------------------|---------|
| | Quasi-peak | Average |
| 0.15 ~ 0.5 | 84-74 | 74-64 |
| 0.50 ~ 30 | 74 | 64 |

Remark: * means decreasing linearly with logarithm of frequency.
The lower limit shall apply at the transition frequencies.

5.3 TEST PROCEDURE

The EUT is put on the plane 0.8m high above the ground by insulating support and selecting ISN for unscreened cable or a current probe for screened cable to take measurement. The port of the EUT was connected to the remote side support equipment through the ISN/Current Probe and communication in normal condition. Making a overall range scan by using the test receiver controlled by controller and record at least six highest emissions for showing in the test report.

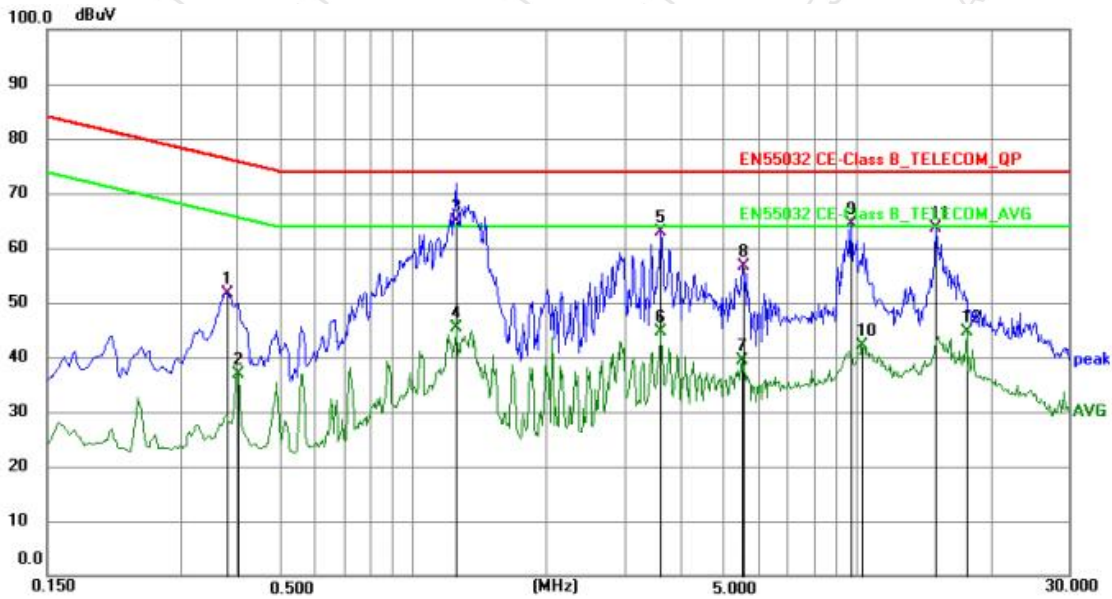
The bandwidth of the field strength meter is set at 9kHz.

The frequency range from 150kHz to 30MHz is investigated. The scanning waveform please refer to the next page.



5.4 TEST RESULTS AND DATA

EUT: Analog Gateway
M/N: MAG1100
Test Mode: Normal Working
Test Voltage : AC 230V/50Hz
Temperature: 23°C
Humidity: 55%
Atmosphere pressure: 101Kpa
Test Results: Pass



| No. | Frequency (MHz) | Reading (dBuV) | Factor (dB) | Level (dBuV) | Limit (dBuV) | Margin (dB) | Detector | P/F |
|-----|-----------------|----------------|-------------|--------------|--------------|-------------|----------|-----|
| 1 | 0.3795 | 31.52 | 20.21 | 51.73 | 76.29 | -24.56 | QP | P |
| 2 | 0.4020 | 16.79 | 20.19 | 36.98 | 65.81 | -28.83 | AVG | P |
| 3 * | 1.2615 | 44.88 | 20.02 | 64.90 | 74.00 | -9.10 | QP | P |
| 4 | 1.2615 | 25.25 | 20.02 | 45.27 | 64.00 | -18.73 | AVG | P |
| 5 | 3.6150 | 43.04 | 19.93 | 62.97 | 74.00 | -11.03 | QP | P |
| 6 | 3.6150 | 24.70 | 19.93 | 44.63 | 64.00 | -19.37 | AVG | P |
| 7 | 5.5130 | 19.47 | 19.91 | 39.38 | 64.00 | -24.62 | AVG | P |
| 8 | 5.5580 | 36.81 | 19.91 | 56.72 | 74.00 | -17.28 | QP | P |
| 9 | 9.7520 | 44.50 | 19.92 | 64.42 | 74.00 | -9.58 | QP | P |
| 10 | 10.2745 | 22.27 | 19.92 | 42.19 | 64.00 | -21.81 | AVG | P |
| 11 | 15.1255 | 43.58 | 19.95 | 63.53 | 74.00 | -10.47 | QP | P |
| 12 | 17.6950 | 24.53 | 20.01 | 44.54 | 64.00 | -19.46 | AVG | P |



6 - RADIATED DISTURBANCE MEASUREMENT

6.1 BLOCK DIAGRAM OF TEST SETUP

Below 1GHz

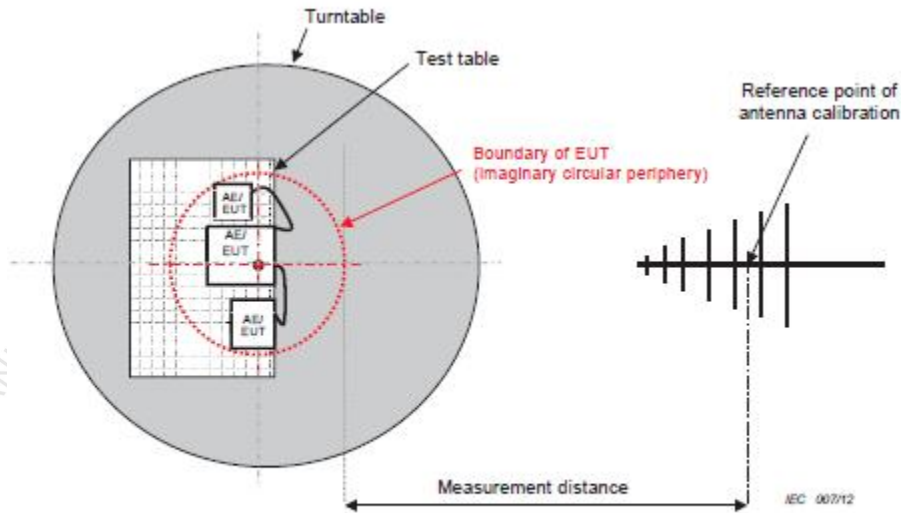


Figure C.1 – Measurement distance

Above 1GHz

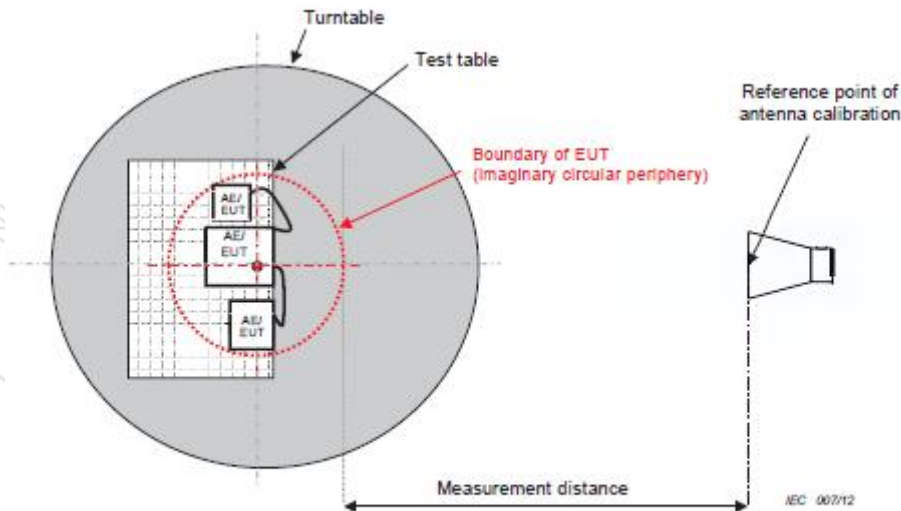


Figure C.1 – Measurement distance

6.2 LIMITS

Below 1GHz

| Frequency (MHz) | Quasi-peak Limits at 3m dB(μ V/m) |
|-----------------|--|
| 30-230 | 40 |
| 230-1000 | 47 |

NOTE: The lower limit shall apply at the transition frequencies.



Above 1GHz

| Frequency (MHz) | Class B Limits at 3m | |
|-----------------|----------------------|---------|
| | Peak dB(μ V/m) | Average |
| 1000-3000 | 70 | 50 |
| 3000-6000 | 74 | 54 |

6.3 TEST PROCEDURE

a. The Product was placed on the non-conductive turntable 0.8/0.1 m above the ground at a chamber.

b. Set the spectrum analyzer/receiver in Peak detector, Max Hold mode, and 120 kHz RBW(Below 1GHz), 1MHz RBW(Above 1GHz). Record the maximum field strength of all the pre-scan process in the full band when the antenna is varied between 1~4 m in both horizontal and vertical, and the turntable is rotated from 0 to 360 degrees.

c. For each frequency whose maximum record was higher or close to limit, measure its QP or peak value: vary the antenna's height and rotate the turntable from 0 to 360 degrees to find the height and degree where Product radiated the maximum emission, then set the test frequency analyzer/receiver to QP Detector / peak / AVG, and specified bandwidth with Maximum Hold Mode, and record the maximum value.



6.4 TEST RESULTS AND DATA

EUT: Analog Gateway
 M/N: MAG1100
 Test Mode: Normal Working
 Test Voltage : AC 230V/50Hz
 Temperature: 26°C
 Humidity: 54%
 Atmosphere pressure: 101Kpa
 Test Results: Pass

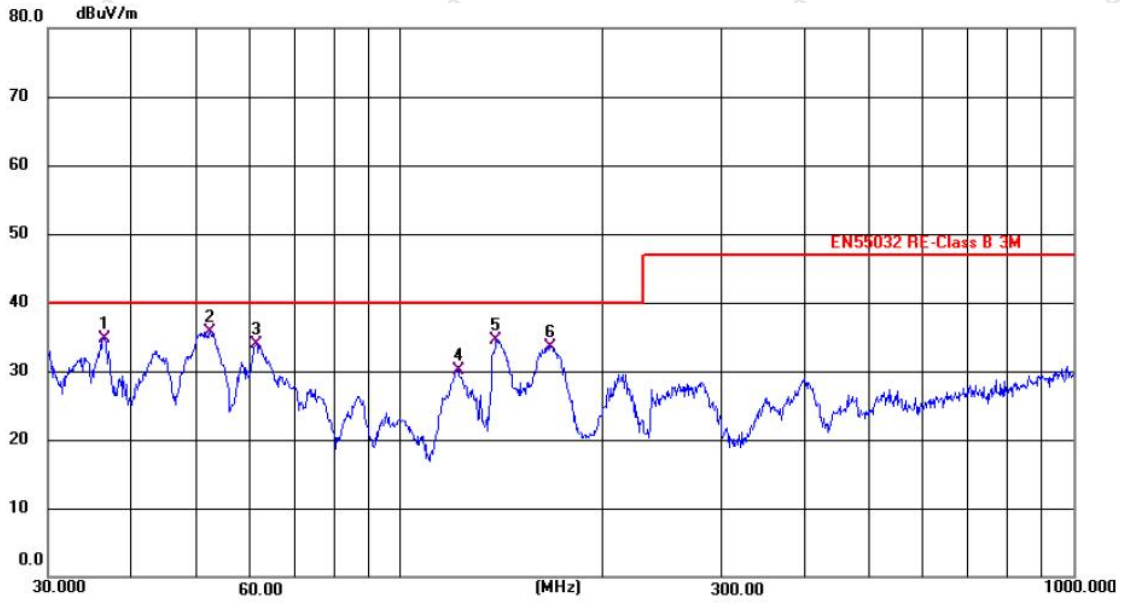
Below 1GHz
 Polarization:Horizontal



| No. | Frequency (MHz) | Reading (dBUV) | Factor (dB/m) | Level (dBUV/m) | Limit (dBUV/m) | Margin (dB) | Detector |
|-----|-----------------|----------------|---------------|----------------|----------------|-------------|----------|
| 1 | 36.5092 | 43.46 | -15.23 | 28.23 | 40.00 | -11.77 | QP |
| 2 | 61.3463 | 41.34 | -15.83 | 25.51 | 40.00 | -14.49 | QP |
| 3 | 140.0961 | 48.91 | -15.61 | 33.30 | 40.00 | -6.70 | QP |
| 4 * | 168.4138 | 51.58 | -16.38 | 35.20 | 40.00 | -4.80 | QP |
| 5 | 279.5333 | 45.67 | -14.77 | 30.90 | 47.00 | -16.10 | QP |
| 6 | 510.9386 | 42.13 | -9.16 | 32.97 | 47.00 | -14.03 | QP |



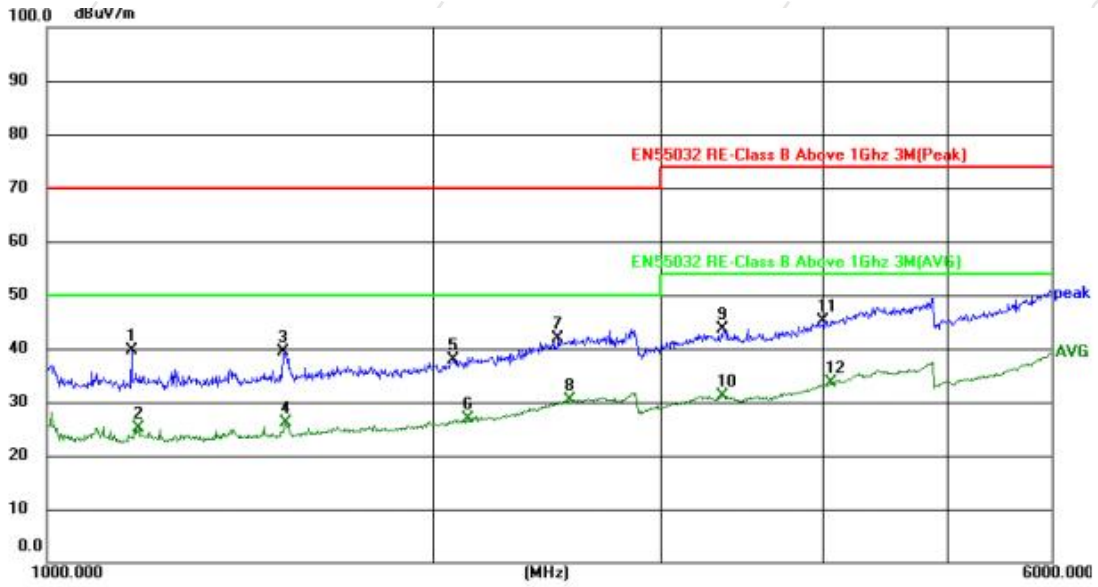
Polarization:Vertical



| No. | Frequency (MHz) | Reading (dBuV) | Factor (dB/m) | Level (dBuV/m) | Limit (dBuV/m) | Margin (dB) | Detector |
|-----|-----------------|----------------|---------------|----------------|----------------|-------------|----------|
| 1 | 36.4451 | 49.91 | -15.20 | 34.71 | 40.00 | -5.29 | QP |
| 2 * | 52.2077 | 51.19 | -15.41 | 35.78 | 40.00 | -4.22 | QP |
| 3 | 61.3462 | 50.28 | -16.40 | 33.88 | 40.00 | -6.12 | QP |
| 4 | 121.9754 | 47.12 | -16.92 | 30.20 | 40.00 | -9.80 | QP |
| 5 | 139.3611 | 50.34 | -15.75 | 34.59 | 40.00 | -5.41 | QP |
| 6 | 167.5302 | 49.53 | -16.00 | 33.53 | 40.00 | -6.47 | QP |



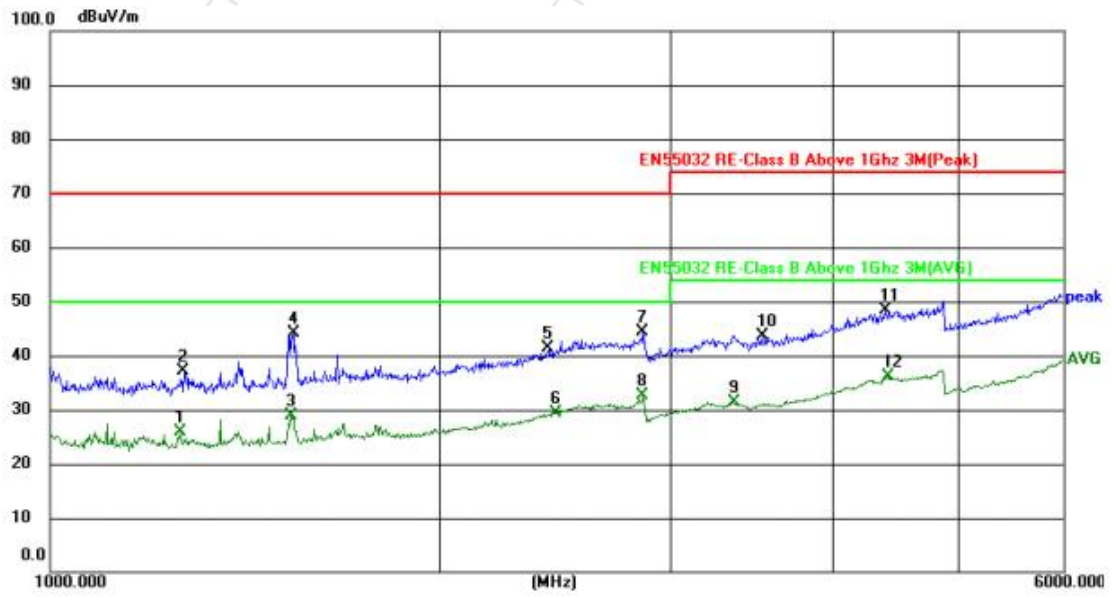
Above 1GHz
Polarization:Horizontal



| No. | Frequency (MHz) | Reading (dBuV) | Factor (dB/m) | Level (dBuV/m) | Limit (dBuV/m) | Margin (dB) | Detector |
|-----|-----------------|----------------|---------------|----------------|----------------|-------------|----------|
| 1 | 1164.509 | 44.95 | -5.35 | 39.60 | 70.00 | -30.40 | peak |
| 2 | 1179.207 | 30.47 | -5.32 | 25.15 | 50.00 | -24.85 | AVG |
| 3 | 1527.681 | 43.58 | -4.25 | 39.33 | 70.00 | -30.67 | peak |
| 4 | 1533.166 | 30.46 | -4.23 | 26.23 | 50.00 | -23.77 | AVG |
| 5 | 2071.660 | 40.40 | -2.64 | 37.76 | 70.00 | -32.24 | peak |
| 6 | 2122.382 | 29.50 | -2.50 | 27.00 | 50.00 | -23.00 | AVG |
| 7 | 2493.774 | 43.26 | -1.42 | 41.84 | 70.00 | -28.16 | peak |
| 8 * | 2550.257 | 31.71 | -1.22 | 30.49 | 50.00 | -19.51 | AVG |
| 9 | 3351.599 | 43.42 | 0.24 | 43.66 | 74.00 | -30.34 | peak |
| 10 | 3351.599 | 30.99 | 0.24 | 31.23 | 54.00 | -22.77 | AVG |
| 11 | 4005.697 | 41.58 | 3.53 | 45.11 | 74.00 | -28.89 | peak |
| 12 | 4059.890 | 30.00 | 3.62 | 33.62 | 54.00 | -20.38 | AVG |



Polarization:Vertical

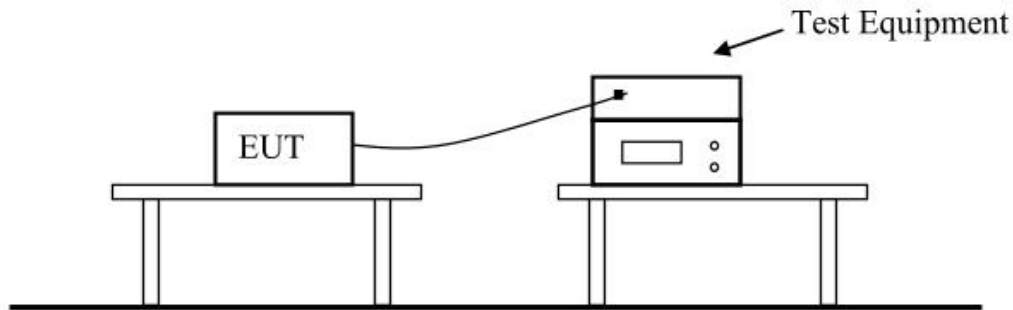


| No. | Frequency (MHz) | Reading (dBuV) | Factor (dB/m) | Level (dBuV/m) | Limit (dBuV/m) | Margin (dB) | Detector |
|-----|-----------------|----------------|---------------|----------------|----------------|-------------|----------|
| 1 | 1260.032 | 30.84 | -5.07 | 25.77 | 50.00 | -24.23 | AVG |
| 2 | 1270.232 | 42.13 | -5.03 | 37.10 | 70.00 | -32.90 | peak |
| 3 | 1531.793 | 33.18 | -4.24 | 28.94 | 50.00 | -21.06 | AVG |
| 4 | 1540.049 | 48.38 | -4.21 | 44.17 | 70.00 | -25.83 | peak |
| 5 | 2416.793 | 43.08 | -1.65 | 41.43 | 70.00 | -28.57 | peak |
| 6 | 2451.685 | 31.02 | -1.54 | 29.48 | 50.00 | -20.52 | AVG |
| 7 | 2855.009 | 44.43 | -0.15 | 44.28 | 70.00 | -25.72 | peak |
| 8 * | 2855.009 | 32.66 | -0.15 | 32.51 | 50.00 | -17.49 | AVG |
| 9 | 3363.631 | 31.16 | 0.24 | 31.40 | 54.00 | -22.60 | AVG |
| 10 | 3530.356 | 43.22 | 0.39 | 43.61 | 74.00 | -30.39 | peak |
| 11 | 4388.983 | 44.16 | 4.20 | 48.36 | 74.00 | -25.64 | peak |
| 12 | 4404.739 | 31.87 | 4.23 | 36.10 | 54.00 | -17.90 | AVG |



7 - HARMONIC CURRENT EMISSION MEASUREMENT

7.1 BLOCK DIAGRAM OF TEST SETUP



7.2 TEST STANDARD

Please refer to EN IEC 61000-3-2:2019+A1:2021

7.3 TEST PROCEDURE

- The Product was placed on the top of a non-conductive table above the ground and operated to produce the maximum harmonic components under normal Test Modes for each successive harmonic component in turn.
- The correspondent test program of test instrument to measure the current harmonics emanated from Product was chosen. The measure time shall be not less than the time necessary for the Product to be exercised.

7.4 TEST RESULTS

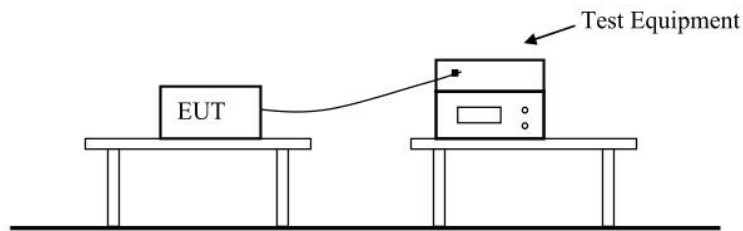
PASS

Because power of EUT's rated power is 37W and less than 75W, According standard EN IEC 61000-3-2:2019+A1:2021, the result no judgment.



8 - VOLTAGE FLUCTUATION AND FLICKER MEASUREMENT

8.1 BLOCK DIAGRAM OF TEST SETUP



8.2 TEST STANDARD

Please refer to EN 61000-3-3:2013+A1:2019+A2:2021

8.3 TEST PROCEDURE

- The Product was placed on the top of a non-conductive table above the ground and operated to produce the most unfavorable sequence of voltage changes under normal Test Modes.
- During the flick test, the measure time shall include that part of whole operation cycle in which the Product procedure the most unfavorable sequence of voltage changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.

8.4 TEST RESULTS

PASS

The active power of the EUT is about 37W only, which unlikely to produce significant voltage fluctuation. Therefore no test was applied.

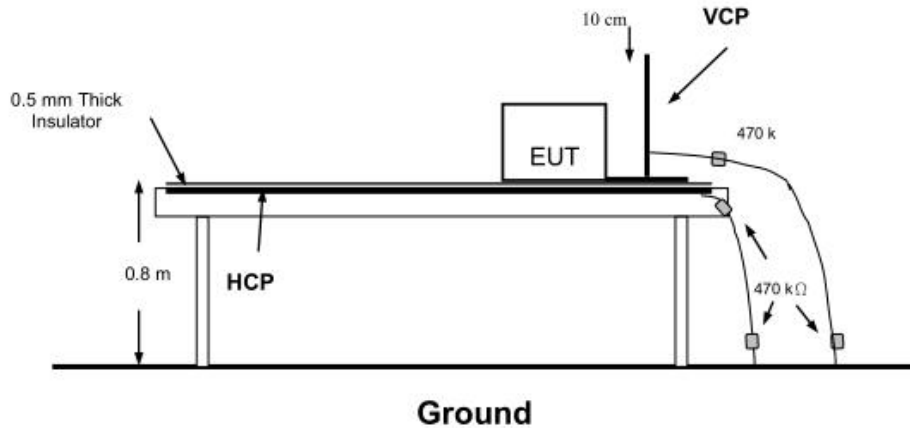
See “EN 61000-3-3:2013+A1:2019+A2:2021, clause 6.1” Tests need not be made on equipment which is unlikely to produce significant voltage fluctuations or flicker....” .



9 - IMMUNITY TEST

9.1 ELECTROSTATIC DISCHARGE IMMUNITY TEST

9.1.1 BLOCK DIAGRAM OF TEST SETUP



9.1.2 TEST SPECIFICATION

| | |
|---------------------|-------------------------------------|
| Basic Standard | : IEC 61000-4-2:2008 |
| Test Port | : Enclosure port |
| Discharge Impedance | : 330 ohm / 150 pF |
| Discharge Mode | : Single Discharge |
| Discharge Period | : one second between each discharge |

9.1.3 TEST PROCEDURE

9.1.3.1. Air Discharge

This test is done on a non-conductive surface. The round discharge tip of the discharge electrode shall be approached as fast as possible to touch the EUT. After each discharge, the discharge electrode shall be removed from the EUT. The generator is then re-triggered for a new single discharge and repeated 10 times for each pre-selected test point. This procedure shall be repeated until all the air discharge completed.

9.1.3.2. Contact Discharge

All the procedure shall be same as Section 9.1.3.1. except that the tip of the discharge electrode shall touch the EUT before the discharge switch is operated.

9.1.3.3. Indirect Discharge for Horizontal Coupling Plane

At least 10 single discharges (in the most sensitive polarity) shall be applied at the front edge of each HCP opposite the center point of each unit (if applicable) of the EUT and 0.1m from the front of the EUT. The long axis of the discharge electrode shall be in the plane of the HCP and perpendicular to its front edge during the discharge.

9.1.3.4. Indirect Discharge for Vertical Coupling Plane

At least 10 single discharges (in the most sensitive polarity) shall be applied to the center of one vertical edge of the coupling plane. The coupling plane, of dimensions 0.5m X 0.5m, is placed parallel to, and positioned at a distance of 0.1m from the EUT. Discharges shall be applied to the coupling plane, with this plane in sufficient different positions that the four faces of the EUT are completely illuminated.



9.1.4 TEST RESULTS

| Electrostatic Discharge | |
|-------------------------|--------------------|
| Basic Standard: | IEC 61000-4-2:2008 |
| EUT: | Analog Gateway |
| M/N: | MAG1100 |
| Test Mode: | Normal Working |
| Test Voltage: | AC 230V/50Hz |
| Temperature: | 24.4°C |
| Humidity: | 58% |
| Atmosphere pressure: | 101Kpa |

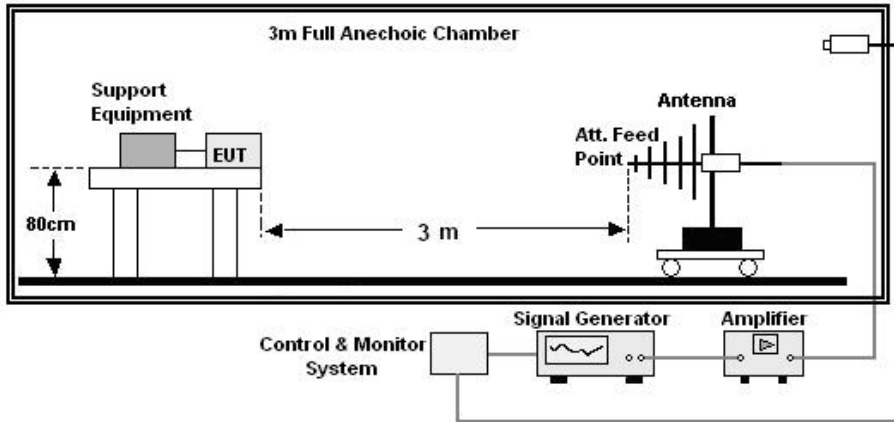
| Discharge Method | Discharge Position | Voltage (±kV) | Min. No. of Discharge per polarity (Each Point) | Performance criteria | Result |
|-------------------|---|---------------|---|----------------------|--------|
| Contact Discharge | Conductive Surfaces | 4 | 10 | B | Pass |
| | Indirect Discharge HCP | 4 | 10 | B | Pass |
| | Indirect Discharge VCP | 4 | 10 | B | Pass |
| Air Discharge | Slots, Apertures, and Insulating Surfaces | 8 | 10 | B | Pass |



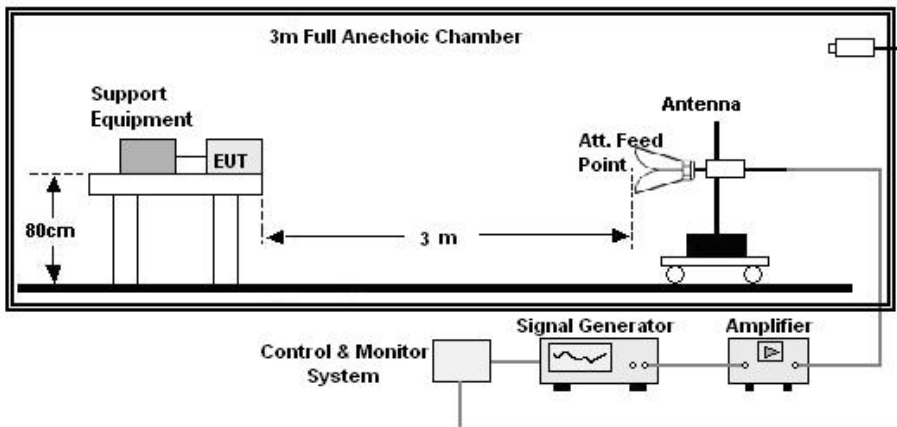
9.2 RADIO FREQUENCY ELECTROMAGNETIC FIELDS

9.2.1 BLOCK DIAGRAM OF TEST SETUP

80-1000MHz:



1000-6000MHz:



9.2.2 TEST SPECIFICATION

| | |
|----------------|-------------------------|
| Basic Standard | : IEC 61000-4-3:2020 |
| Test Port | : Enclosure port |
| Step Size | : 1% |
| Modulation | : 1kHz, 80% AM |
| Dwell Time | : 1 second |
| Polarization | : Horizontal & Vertical |

9.2.3 TEST PROCEDURE

- The testing was performed in a fully-anechoic chamber. The transmit antenna was located at a distance of 3 meters from the Product.
- The frequency range is swept from 80MHz to 1000MHz, 1800MHz, 2600MHz, 3500MHz, 5000MHz, with the signal 80% amplitude modulated with a 1 kHz sine wave. The rate of sweep did not exceed 1.5×10^{-3} decade/s. Where the frequency range is swept incrementally, the step size was 1%.
- The test was performed with the Product exposed to both vertically and horizontally polarized fields on each of the four sides.



9.2.4 TEST RESULTS

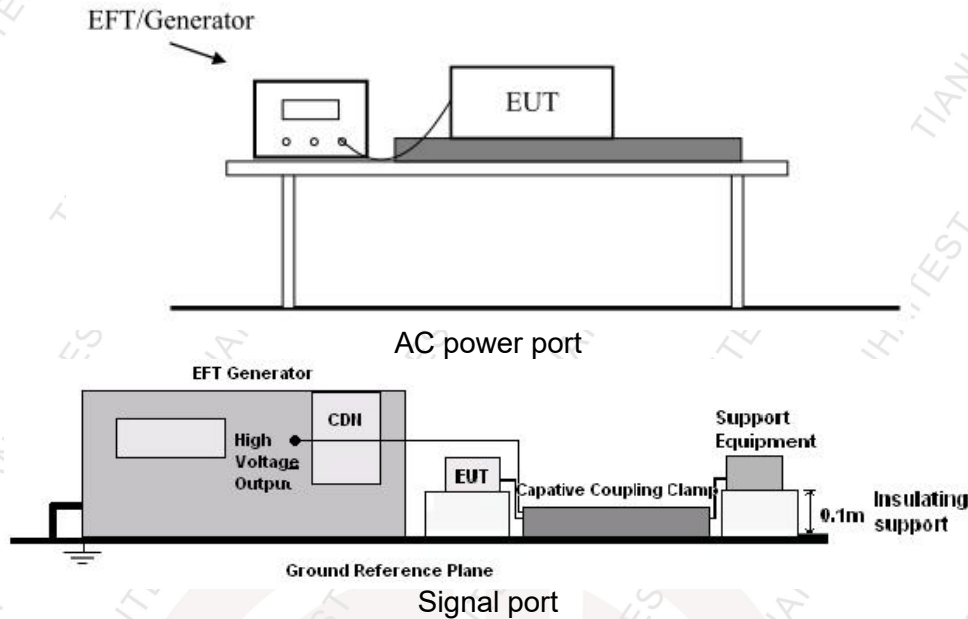
| Radio frequency electromagnetic fields | |
|--|--------------------|
| Basic Standard: | IEC 61000-4-3:2020 |
| EUT: | Analog Gateway |
| M/N: | MAG1100 |
| Test Mode: | Normal Working |
| Test Voltage: | AC 230V/50Hz |
| Temperature: | 24.4℃ |
| Humidity: | 58% |
| Atmosphere pressure: | 101Kpa |

| Frequency (MHz) | Position | Field Strength (V/m) | Performance criteria | Result |
|-----------------|----------|----------------------|----------------------|--------|
| 80 - 1000 | Front | 3 | A | Pass |
| | Right | 3 | A | Pass |
| | Back | 3 | A | Pass |
| | Left | 3 | A | Pass |
| 1800 | Front | 3 | A | Pass |
| | Right | 3 | A | Pass |
| | Back | 3 | A | Pass |
| | Left | 3 | A | Pass |
| 2600 | Front | 3 | A | Pass |
| | Right | 3 | A | Pass |
| | Back | 3 | A | Pass |
| | Left | 3 | A | Pass |
| 3500 | Front | 3 | A | Pass |
| | Right | 3 | A | Pass |
| | Back | 3 | A | Pass |
| | Left | 3 | A | Pass |
| 5000 | Front | 3 | A | Pass |
| | Right | 3 | A | Pass |
| | Back | 3 | A | Pass |
| | Left | 3 | A | Pass |



9.3 ELECTRICAL FAST TRANSIENT/BURST IMMUNITY TEST

9.3.1 BLOCK DIAGRAM OF TEST SETUP



9.3.2 TEST SPECIFICATION

| | |
|--------------------|--------------------------------------|
| Basic Standard | : IEC 61000-4-4:2012 |
| Test Port | : input a.c.power port / signal port |
| Impulse Frequency | : 5 kHz |
| Impulse Wave-shape | : 5/50 ns |
| Burst Duration | : 15 ms |
| Burst Period | : 300 ms |
| Test Duration | : 2 minutes per polarity |

9.3.3 TEST PROCEDURE

The EUT is put on the table which is 0.8 meter high above the ground. This reference ground plane shall project beyond the EUT by at least 0.1m on all sides and the minimum distance between EUT and all other conductive structure, except the ground plane beneath the EUT, shall be more than 0.5m.

9.3.3.1. For input and output AC power ports:

The EUT is connected to the AC power by using a coupling device which couples the EFT interference signal to AC power lines. Both polarities of the test voltage should be applied during compliance test and the duration of the test is 2 mins.

9.3.3.2. For signal lines and control lines ports:

The EUT is connected to the signal line by using a coupling device which couples the EFT interference signal to signal lines. Both polarities of the test voltage should be applied during compliance test and the duration of the test is 2 mins.

No I/O ports. It's unnecessary to test.

9.3.3.3. For DC output line ports:

No DC output ports. It's unnecessary to test.



9.3.4 TEST RESULTS

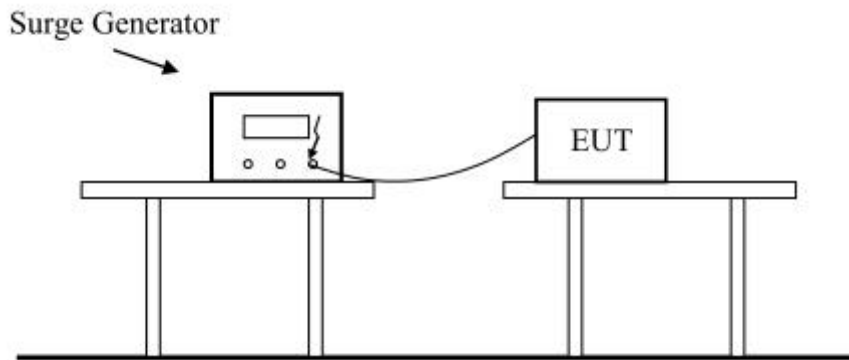
| Electrical Fast Transient/Burst | |
|---------------------------------|--------------------|
| Basic Standard: | IEC 61000-4-4:2012 |
| EUT: | Analog Gateway |
| M/N: | MAG1100 |
| Test Mode: | Normal Working |
| Test Voltage: | AC 230V/50Hz |
| Temperature: | 24.4℃ |
| Humidity: | 58% |
| Atmosphere pressure: | 101Kpa |

| Line | Test Voltage | Performance criteria | Result |
|--------|--------------|----------------------|--------|
| L | ±1kV | B | Pass |
| N | ±1kV | B | Pass |
| L-N | ±1kV | B | Pass |
| PE | ±1kV | B | Pass |
| L-PE | ±1kV | B | Pass |
| N-PE | ±1kV | B | Pass |
| L-N-PE | ±1kV | B | Pass |
| LAN | ±0.5kV | B | Pass |



9.4 SURGE IMMUNITY TEST

9.4.1 BLOCK DIAGRAM OF TEST SETUP



9.4.2 TEST SPECIFICATION

| | |
|-----------------------|---|
| Basic Standard | IEC 61000-4-5:2014+AMD1:2017 |
| Test Port | input a.c. power port /signal port |
| Wave-Shape | Open Circuit Voltage - 1.2 / 50 us, 10/700us Short Circuit Current - 8 / 20 us, 5/320us |
| Pulse Repetition Rate | 1 pulse / min. |
| Test Events | Five positive polarity pulses at the 90° phase angel Five negative polarity pulses at the 270° phase angel |

9.4.3 TEST PROCEDURE

9.4.1.1. Set up the EUT and test generator as shown on Section 9.4.1.

9.4.1.2. For line to line coupling mode, provide a 1.0 KV 1.2/50us voltage surge (at open-circuit condition) and 8/20us current surge to EUT selected points.

9.4.1.3. For Lan port to ground coupling mode, provide a 0.5 KV 10/700us voltage surge (at open-circuit condition) and 5/320us current surge to EUT selected points.

9.4.1.4. At least 5 positive and 5 negative (polarity) tests with a maximum 1/min repetition rate are conducted during test

9.4.1.5. Different phase angles are done individually.

9.4.1.6. Record the EUT operating situation during compliance test and decide the EUT immunity criterion for above each test.



9.4.4 TEST RESULTS

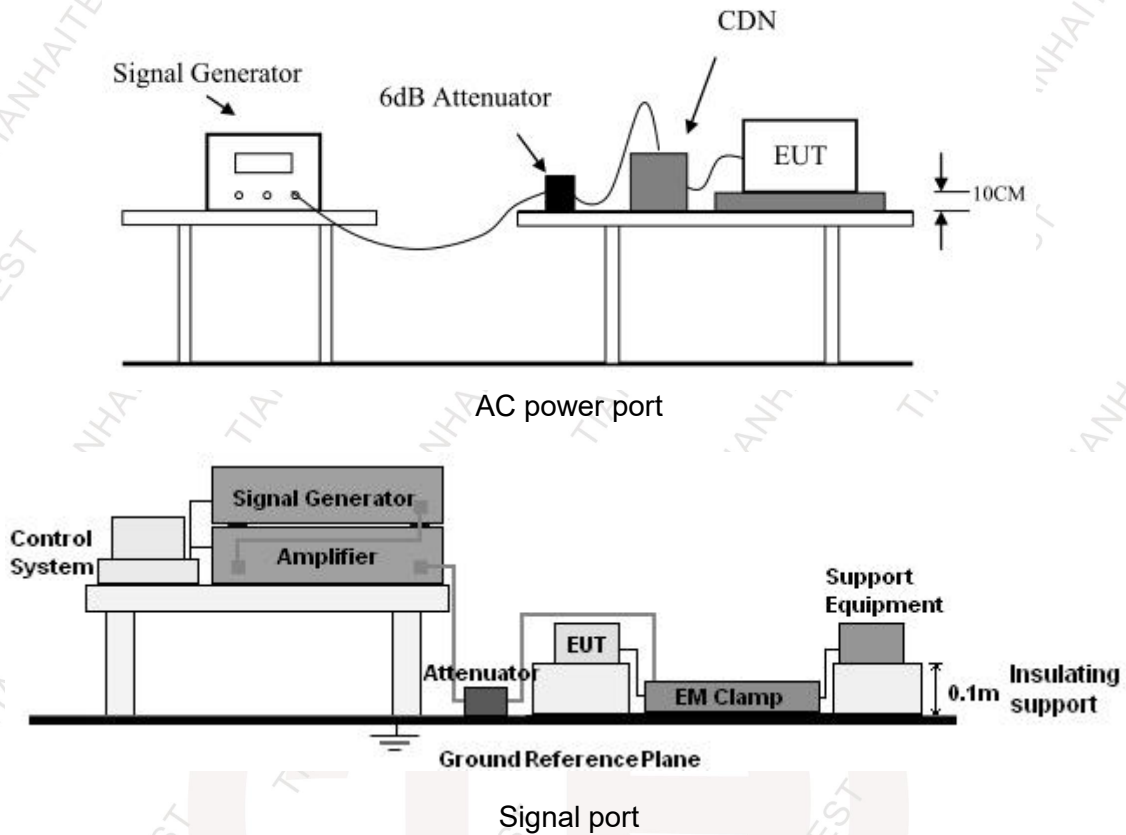
| SURGE IMMUNITY | |
|----------------------|------------------------------|
| Basic Standard: | IEC 61000-4-5:2014+AMD1:2017 |
| EUT: | Analog Gateway |
| M/N: | MAG1100 |
| Test Mode: | Normal Working |
| Test Voltage: | AC 230V/50Hz |
| Temperature: | 24.4°C |
| Humidity: | 58% |
| Atmosphere pressure: | 101Kpa |

| Line | Phase Angle | Test Voltage | Number of Pulse | Performance criteria | Result |
|------|-------------|--------------|-----------------|----------------------|--------|
| L-N | 90° | + 1kV | 5 | B | Pass |
| | 270° | - 1kV | 5 | B | Pass |
| L-PE | 90° | + 2kV | 5 | B | Pass |
| | 270° | - 2kV | 5 | B | Pass |
| N-PE | 90° | - 2kV | 5 | B | Pass |
| | 270° | + 2kV | 5 | B | Pass |
| LAN | / | ±0.5kV | 5 | B | Pass |



9.5 INJECTED CURRENTS SUSCEPTIBILITY TEST

9.5.1 BLOCK DIAGRAM OF TEST SETUP



9.5.2 TEST SPECIFICATION

| | |
|----------------|---------------------------------------|
| Basic Standard | : IEC 61000-4-6:2013 |
| Test Port | : input a.c. power port / signal port |
| Step Size | : 1% |
| Modulation | : 1kHz,80% AM |
| Dwell Time | : 1 second |

9.5.3 TEST PROCEDURE

For a.c. / d.c. power port

9.5.3.1. Set up the EUT, CDN and test generators as shown on Section 9.5.1.

9.5.3.2. Let the EUT work in test mode and measure it.

9.5.3.3. The EUT are placed on an insulating support 0.1m high above a ground reference plane. CDN (coupling and decoupling device) is placed on the ground plane about 0.3m from EUT. Cables between CDN and EUT are as short as possible, and their height above the ground reference plane shall be between 30 and 50 mm (where possible).

9.5.3.4. The disturbance signal described below is injected to EUT through CDN.

9.5.3.5. The EUT operates within its operational mode(s) under intended climatic conditions after power on.

9.5.3.6. The frequency range is swept from 150kHz to 10MHz using 3V, 10MHz to 30MHz using 3V to 1V,30MHz to 80MHz using 1V signal level, and with the disturbance signal 80% amplitude



modulated with a 1kHz sine wave.

9.5.3.7. The rate of sweep shall not exceed 1.5×10^{-3} decades/s. Where the frequency is swept incrementally, the step size shall not exceed 1% of the start and thereafter 1% of the preceding frequency value.

9.5.3.8. Recording the EUT operating situation during compliance testing and decide the EUT immunity criterion.

For signal / control lines:

9.5.3.9. The Product and support units were located at a ground reference plane with the interposition of a 0.1 m thickness insulating support, and the telecommunication port under test was connected to support units through the current clamp.

9.5.3.10. The frequency range is swept from 150kHz to 10MHz using 3V, 10MHz to 30MHz using 3V to 1V, 30MHz to 80MHz using 1V signal level, and with the disturbance signal 80% amplitude modulated with a 1kHz sine wave.

9.5.3.11. The rate of sweep shall not exceed 1.5×10^{-3} decades/s. Where the frequency is swept incrementally, the step size shall not exceed 1% of the start and thereafter 1% of the preceding frequency value.

9.5.3.12. Recording the EUT operating situation during compliance testing and decide the EUT immunity criterion.

9.5.4 TEST RESULTS

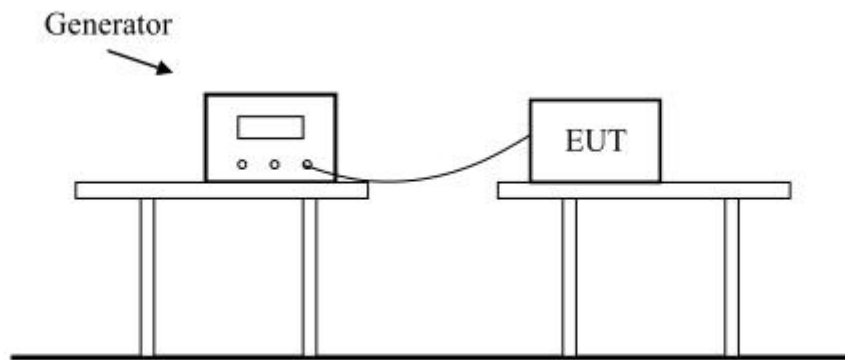
| INJECTED CURRENTS SUSCEPTIBILITY | |
|----------------------------------|--------------------|
| Basic Standard: | IEC 61000-4-6:2013 |
| EUT: | Analog Gateway |
| M/N: | MAG1100 |
| Test Mode: | Normal Working |
| Test Voltage: | AC 230V/50Hz |
| Temperature: | 24.4°C |
| Humidity: | 58% |
| Atmosphere pressure: | 101Kpa |

| Frequency Range (MHz) | Injected Position | Strength (Non-modulated) | Performance criteria | Result |
|-----------------------|-------------------|--------------------------|----------------------|--------|
| 0.15 ~ 10 | AC Mains | 3V r.m.s. | A | Pass |
| 10 ~ 30 | AC Mains | 3V r.m.s. to 1V r.m.s. | A | Pass |
| 30 ~ 80 | AC Mains | 1V r.m.s. | A | Pass |
| 0.15 ~ 10 | LAN | 3V r.m.s. | A | Pass |
| 10 ~ 30 | LAN | 3V r.m.s. to 1V r.m.s. | A | Pass |
| 30 ~ 80 | LAN | 1V r.m.s. | A | Pass |



9.6 VOLTAGE DIPS AND INTERRUPTIONS TEST

9.6.1 BLOCK DIAGRAM OF TEST SETUP



9.6.2 TEST SPECIFICATION

| | |
|----------------|-------------------------|
| Basic Standard | : IEC 61000-4-11:2020 |
| Test Port | : input a.c. power port |
| Phase Angle | : 0°, 180° |

9.6.3 TEST PROCEDURE

9.6.3.1. Set up the EUT and test generator as shown on Section 9.6.1.

9.6.3.2. The interruptions is introduced at selected phase angles with specified duration.

9.6.3.3. Record any degradation of performance.



9.6.4 TEST RESULTS

| VOLTAGE DIPS AND INTERRUPTIONS | |
|--------------------------------|-----------------------------|
| Basic Standard: | IEC 61000-4-11:2020 |
| EUT: | Analog Gateway |
| M/N: | MAG1100 |
| Test Mode: | Normal Working |
| Test Voltage: | AC 230V/50Hz & AC 120V/60Hz |
| Temperature: | 24.4℃ |
| Humidity: | 58% |
| Atmosphere pressure: | 101Kpa |

| AC 230V | | | | |
|--------------------|---|---------------------|-------------------------|--------|
| Test Level % UT | Voltage Dips & Short Interruptions % UT | Duration (cycle) | Performance criteria | Result |
| | | 50Hz | | |
| < 5 | 100 | 0.5 | B | Pass |
| 70 | 30 | 25 | C | Pass |
| < 5 | 100 | 250 | C | Pass |

| AC 120V | | | | |
|--------------------|---|---------------------|-------------------------|--------|
| Test Level % UT | Voltage Dips & Short Interruptions % UT | Duration (cycle) | Performance criteria | Result |
| | | 60Hz | | |
| < 5 | 100 | 0.5 | B | Pass |
| 70 | 30 | 30 | C | Pass |
| < 5 | 100 | 300 | C | Pass |



APPENDIX A - TEST SETUP PHOTOGRAPHS

Photographs 1: Set-up for Conducted disturbance at mains terminals



Photographs 2: Set-up for Asymmetric mode conducted emission

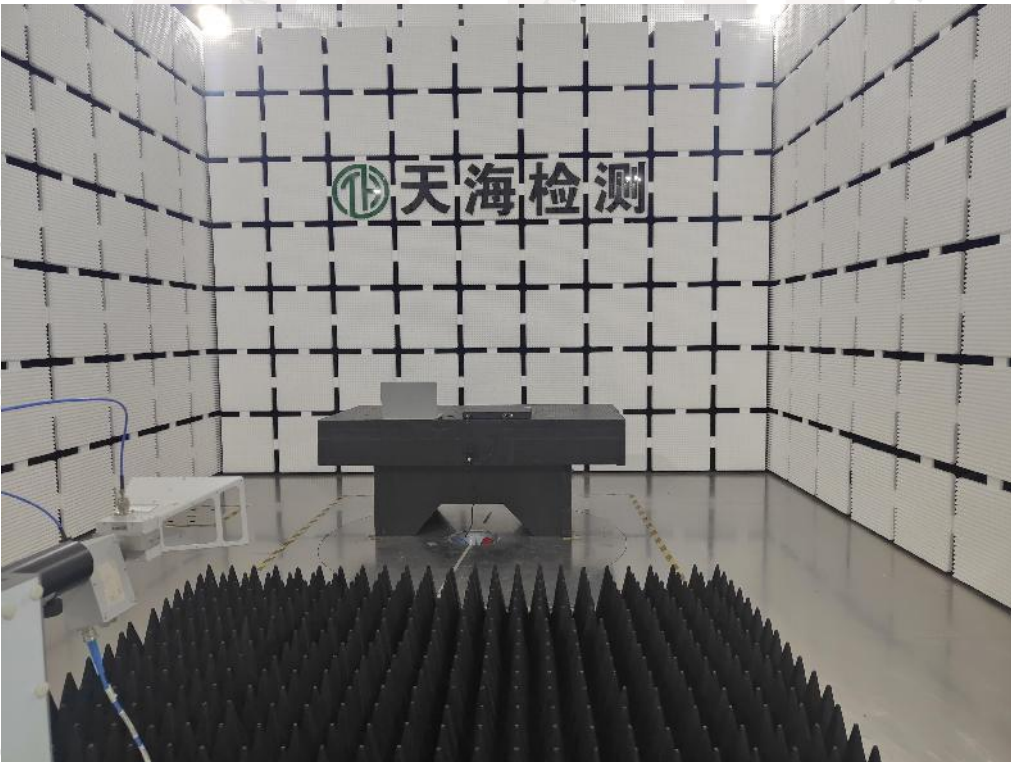




Photographs 3: Set-up for Radiated disturbance(below 1GHz)



Photographs 4: Set-up for Radiated disturbance(above 1GHz)





Photographs 5: Set-up for Electrostatic discharge (ESD)



Photographs 6: Set-up for Radio-frequency, Continuous radiated disturbance(RS)





Photographs 7: Set-up for Electrical fast transient (EFT)-AC power port



Photographs 8: Set-up for Electrical fast transient (EFT)-Signal port





Photographs 9: Set-up for Surge -AC power port



Photographs 10: Set-up for Surge -Signal port





Photographs 11: Set-up for Radio-frequency, Continuous conducted disturbance (CS)-AC power port



Photographs 12: Set-up for Radio-frequency, Continuous conducted disturbance (CS)-Signal port



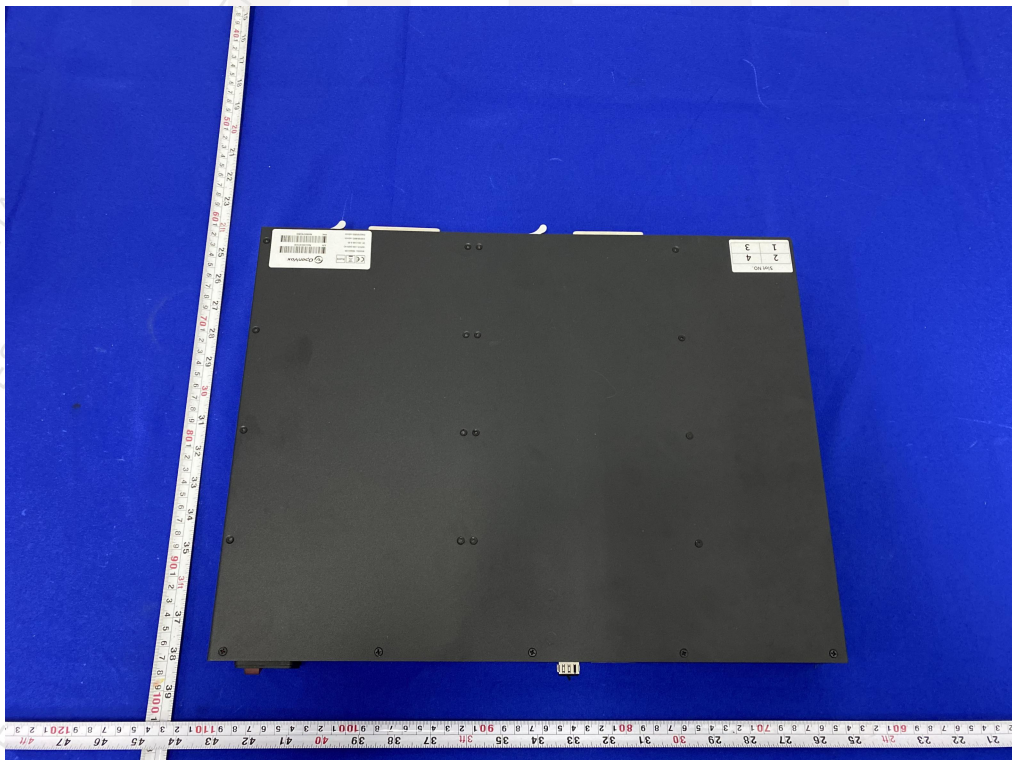


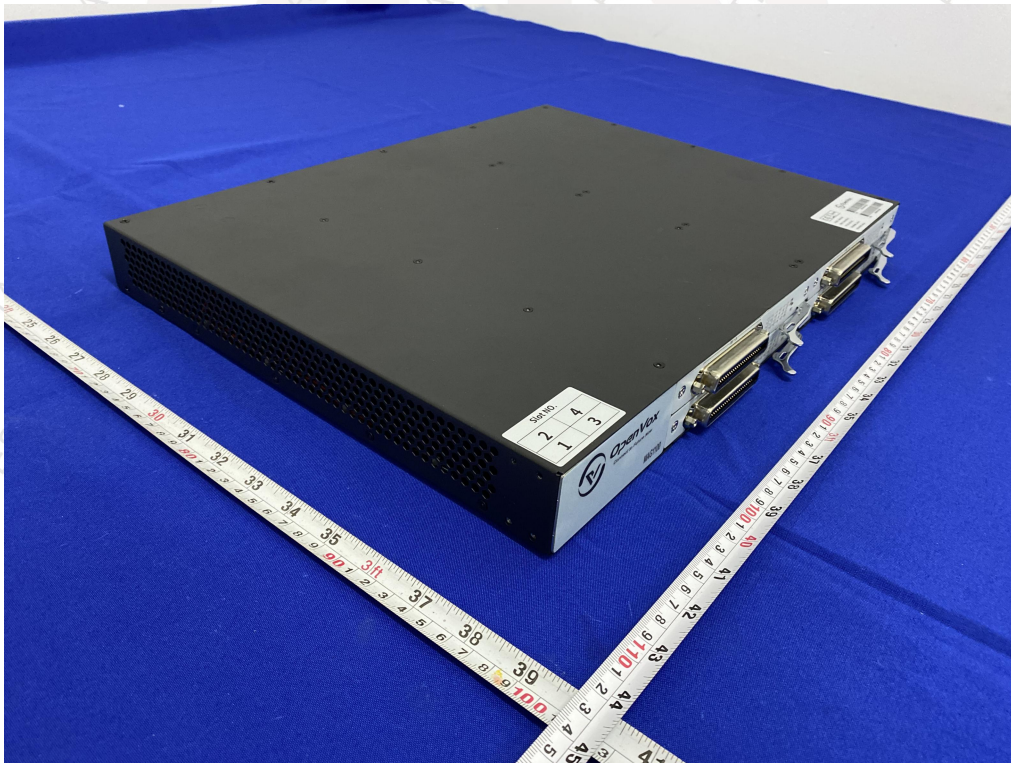
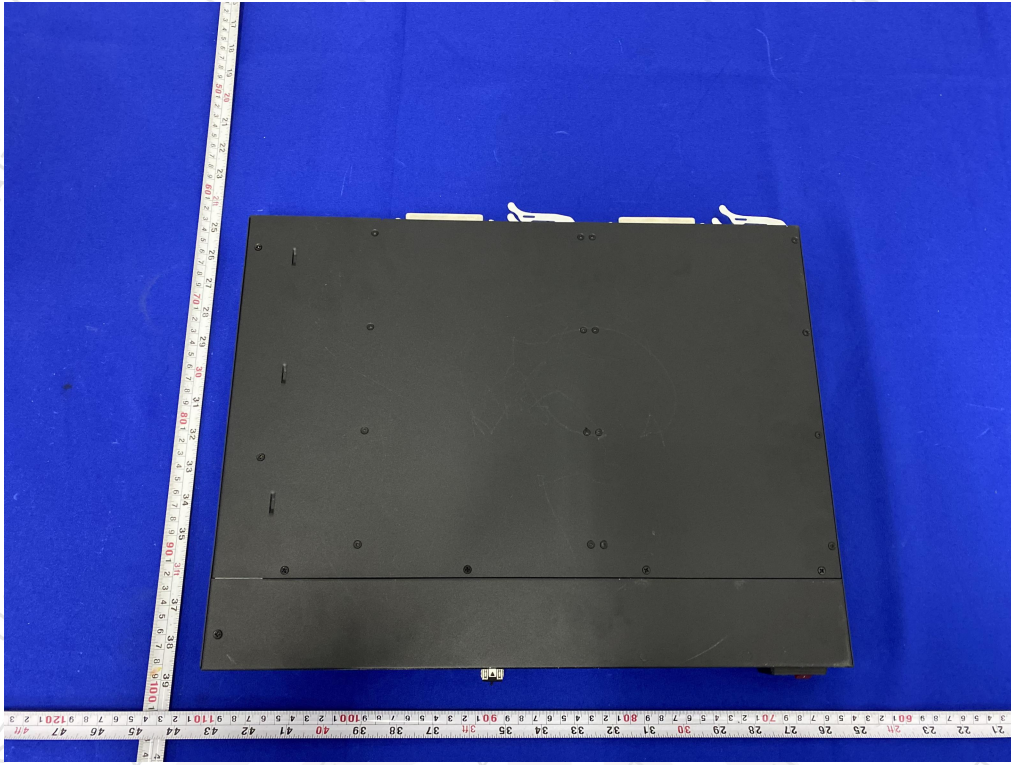
Photographs 13: Set-up for Voltage dips & Voltage interruptions





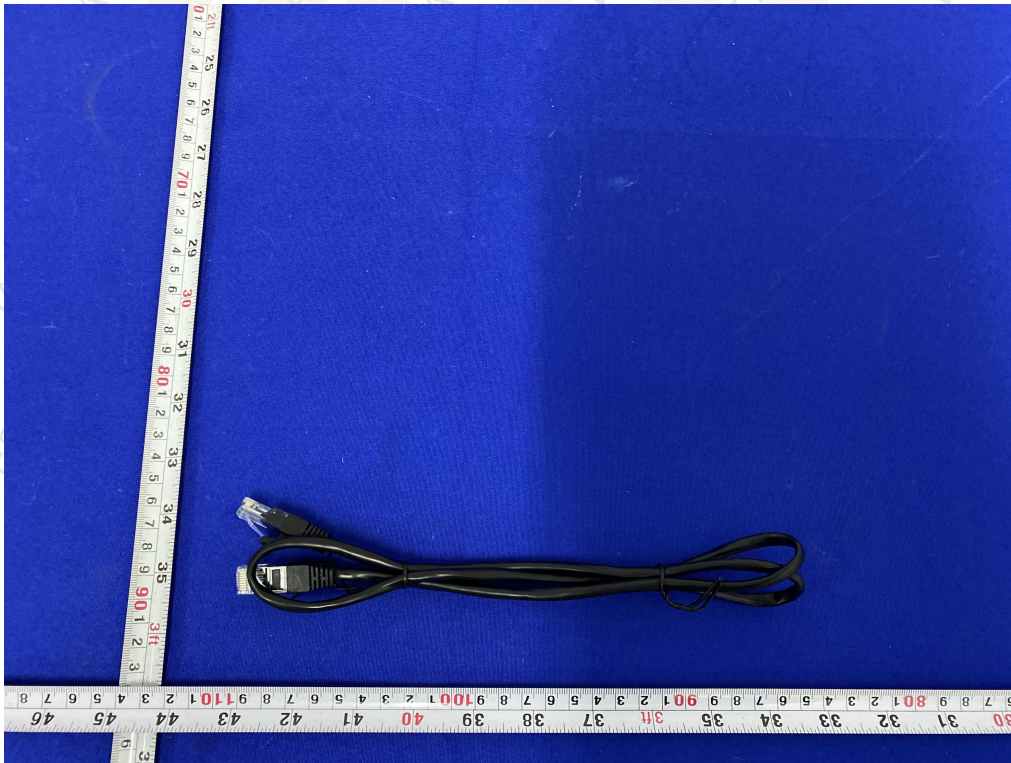
APPENDIX B - EUT PHOTOGRAPHS

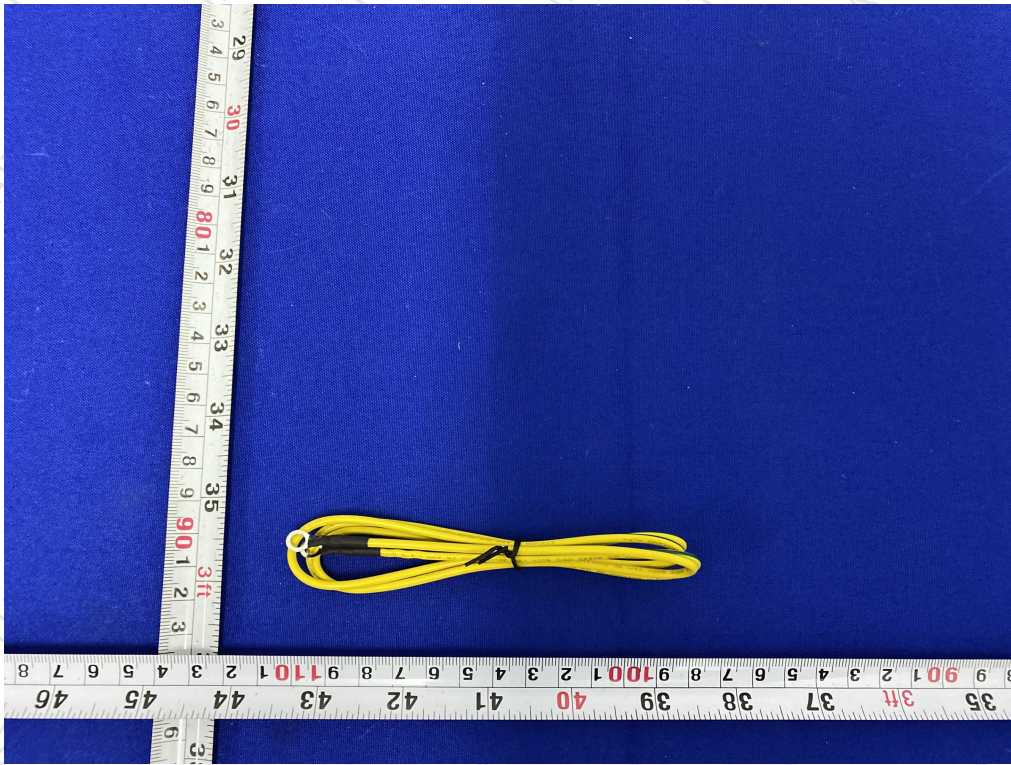


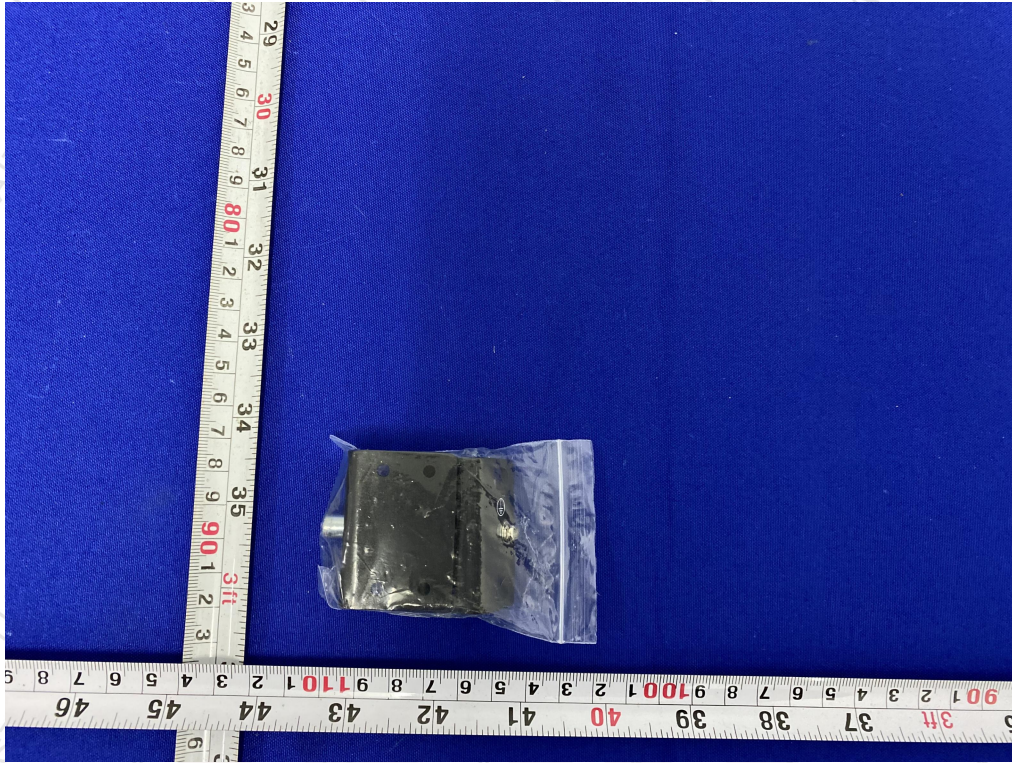












*****END OF THE REPORT*****